## Application/Control No. Applicant(s)/Patent Under Reexamination 10/010,646 HAN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Andrew H. Lee 2877 **U.S. PATENT DOCUMENTS** Document Number Date Country Code-Number-Kind Code Name Classification MM-YYYY US-6,459,487 10-2002 Α Chen et al. 356/491 US-5,675,411 10-1997 В Brooks et al. 356/328 US-С US-D US-Ε F US-US-G Н US-US-1 US-US-Κ US-М US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** \* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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